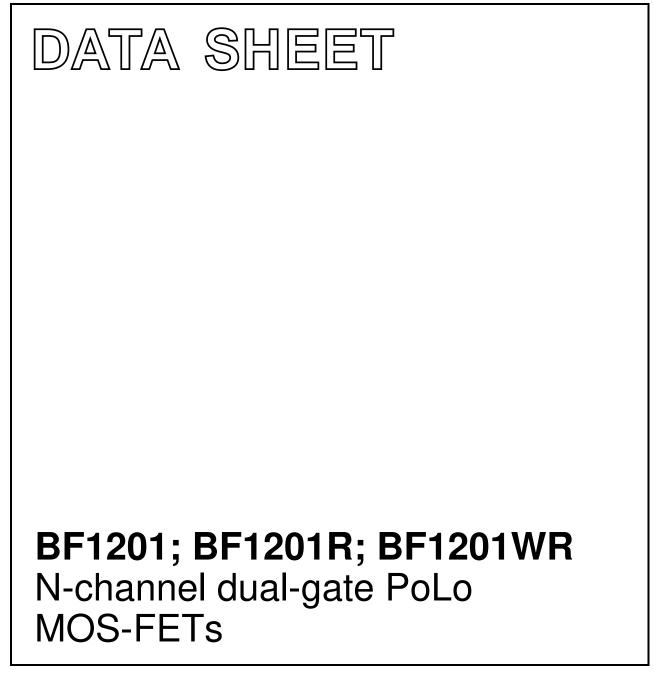
DISCRETE SEMICONDUCTORS



Product specification Supersedes data of 1999 Dec 01 2000 Mar 29



BF1201; BF1201R; BF1201WR

FEATURES

PINNING

PIN

1

2

3

4

- Short channel transistor with high forward transfer admittance to input capacitance ratio
- Low noise gain controlled amplifier
- Partly internal self-biasing circuit to ensure good cross-modulation performance during AGC and good DC stabilization.

APPLICATIONS

• VHF and UHF applications with 3 to 9 V supply voltage, such as digital and analogue television tuners and professional communications equipment.

DESCRIPTION

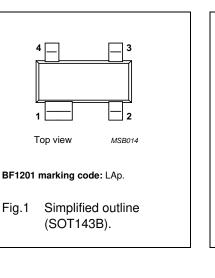
Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1201, BF1201R and BF1201WR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage		_	_	10	V
I _D	drain current		-	-	30	mA
P _{tot}	total power dissipation		-	-	200	mW
y _{fs}	forward transfer admittance		23	28	35	mS
C _{ig1-ss}	input capacitance at gate 1		-	2.6	3.1	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	15	30	fF
F	noise figure	f = 400 MHz	_	1	1.8	dB
X _{mod}	cross-modulation	input level for k = 1% at 40 dB AGC	105	-	-	dBμV
Tj	operating junction temperature		-	-	150	°C

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.



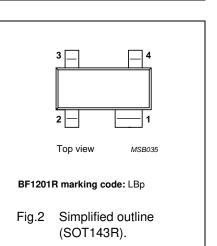
DESCRIPTION

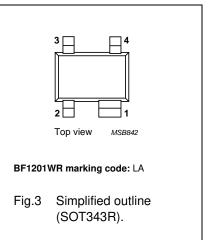
source

drain

gate 2

gate 1





BF1201; BF1201R; BF1201WR

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

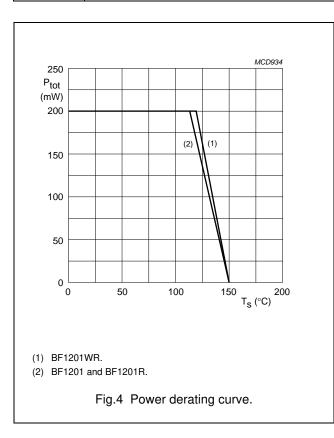
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	10	V
I _D	drain current (DC)		_	30	mA
I _{G1}	gate 1 current		_	±10	mA
I _{G2}	gate 2 current		_	±10	mA
P _{tot}	total power dissipation				
	BF1201; BF1201R	$T_s \le 113 \text{ °C}$; note 1	_	200	mW
	BF1201WR	$T_s \le 109 \ ^\circ C$; note 1	_	200	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	operating junction temperature		-	150	°C

Note

1. $\ T_s$ is the temperature of the soldering point of the source lead.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R _{th j-s}	thermal resistance from junction to soldering point		
	BF1201; BF1201R	185	K/W
	BF1201WR	155	K/W



BF1201; BF1201R; BF1201WR

STATIC CHARACTERISTICS

$T_i = 25 \ ^{\circ}C$; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0; I_D = 10 \ \mu A$	10	_	V
V _{(BR)G1-SS}	gate 1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0; I_{G1-S} = 10 \text{ mA}$	6	_	V
V _{(BR)G2-SS}	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0; I_{G2-S} = 10 \text{ mA}$	6	_	V
V _{(F)S-G1}	forward source-gate 1 voltage	$V_{G2-S} = V_{DS} = 0; I_{S-G1} = 10 \text{ mA}$	0.5	1.5	V
V _{(F)S-G2}	forward source-gate 2 voltage	$V_{G1-S} = V_{DS} = 0; I_{S-G2} = 10 \text{ mA}$	0.5	1.5	V
V _{G1-S(th)}	gate 1-source threshold voltage	V_{G2-S} = 4 V; V_{DS} = 5 V; I_D = 100 μ A	0.3	1.0	V
V _{G2-S(th)}	gate 2-source threshold voltage	$V_{G1-S} = V_{DS} = 5 \text{ V}; \text{ I}_{D} = 100 \mu\text{A}$	0.3	1.2	V
I _{DSX}	drain-source current	$V_{G2\text{-}S}$ = 4 V; V_{DS} = 5 V; R_{G1} = 62 k $\Omega;$ note 1	11	19	mA
I _{G1-SS}	gate 1 cut-off current	$V_{G2-S} = V_{DS} = 0; V_{G1-S} = 5 V$	_	50	nA
I _{G2-SS}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0; V_{G2-S} = 4 V$	-	20	nA

Note

1. R_{G1} connects G_1 to $V_{GG} = 5$ V.

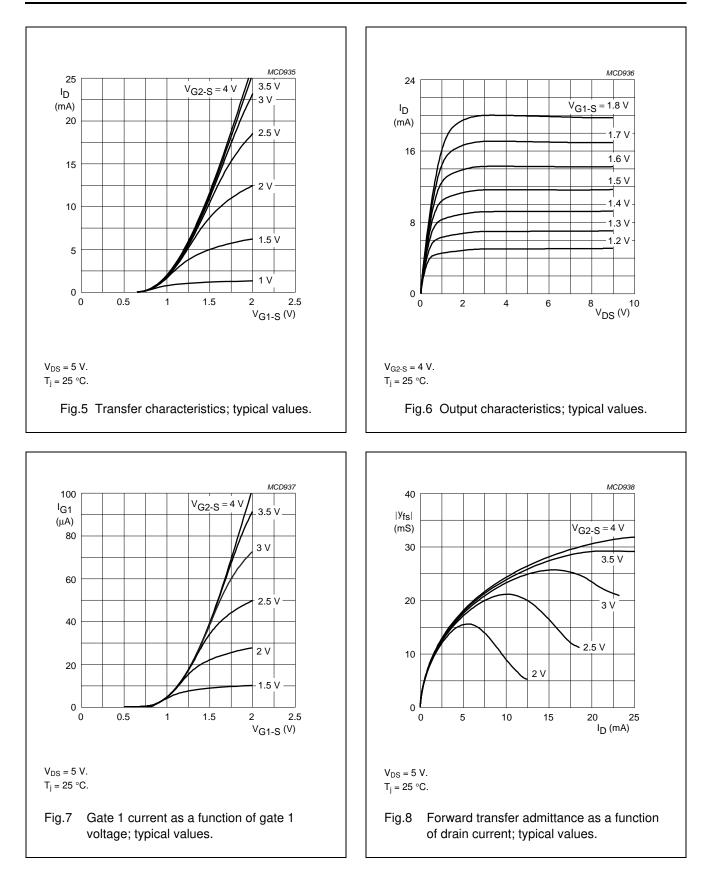
DYNAMIC CHARACTERISTICS

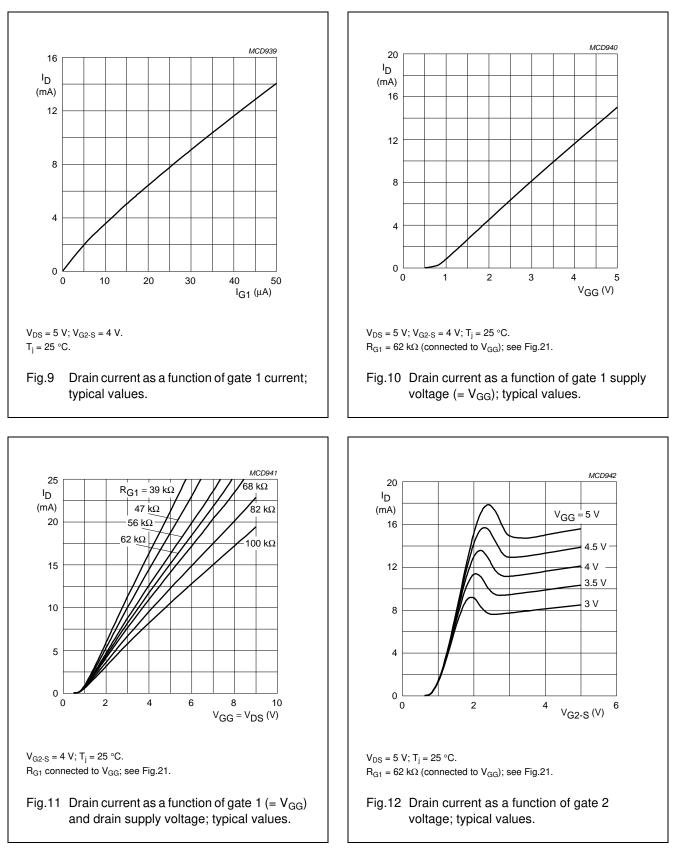
Common source; $T_{amb} = 25 \text{ °C}$; $V_{G2-S} = 4 \text{ V}$; $V_{DS} = 5 \text{ V}$; $I_D = 15 \text{ mA}$; unless otherwise specified.

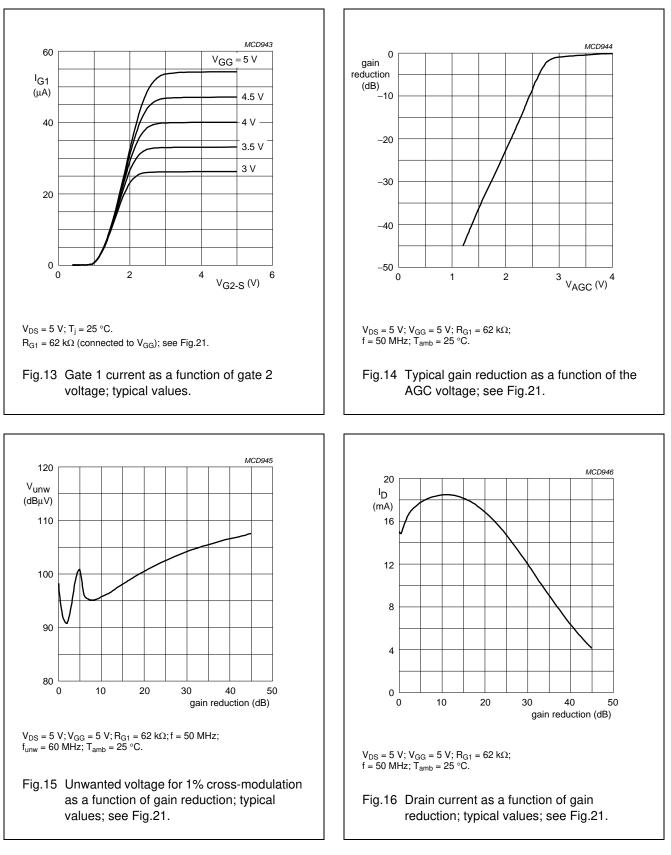
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
y _{fs}	forward transfer admittance	pulsed; T _j = 25 °C	23	28	35	mS
C _{ig1-ss}	input capacitance at gate 1	f = 1 MHz	_	2.6	3.1	pF
C _{ig2-ss}	input capacitance at gate 2	f = 1 MHz	-	1.1	-	pF
C _{oss}	output capacitance	f = 1 MHz	-	0.9	-	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	15	30	fF
F	noise figure	$f = 10.7 \text{ MHz}; G_S = 20 \text{ mS}; B_S = 0$	-	5	7	dB
		$f = 400 \text{ MHz}; Y_S = Y_{S \text{ opt}}$	-	1	1.8	dB
		$f = 800 \text{ MHz}; Y_S = Y_{S \text{ opt}}$	_	1.9	2.5	dB
G _{tr}	power gain	$f = 200 \text{ MHz}; G_S = 2 \text{ mS}; B_S = B_{S \text{ opt}};$ $G_L = 0.5 \text{ mS}; B_L = B_{L \text{ opt}};$	-	33.5	-	dB
		$f = 400 \text{ MHz}; G_S = 2 \text{ mS}; B_S = B_{S \text{ opt}};$ $G_L = 1 \text{ mS}; B_L = B_{L \text{ opt}};$	-	29	-	dB
		$ f = 800 \text{ MHz}; \text{G}_{\text{S}} = 3.3 \text{ mS}; \text{B}_{\text{S}} = \text{B}_{\text{S opt}}; \\ \text{G}_{\text{L}} = 1 \text{ mS}; \text{B}_{\text{L}} = \text{B}_{\text{L opt}}; $	_	24	_	dB
X _{mod}	cross-modulation	input level for k = 1%; f _w = 50 MHz; f _{unw} = 60 MHz; note 1				
		at 0 dB AGC	90	-	_	dBµV
		at 10 dB AGC	-	95	_	dBµV
		at 40 dB AGC	105	_	_	dBµV

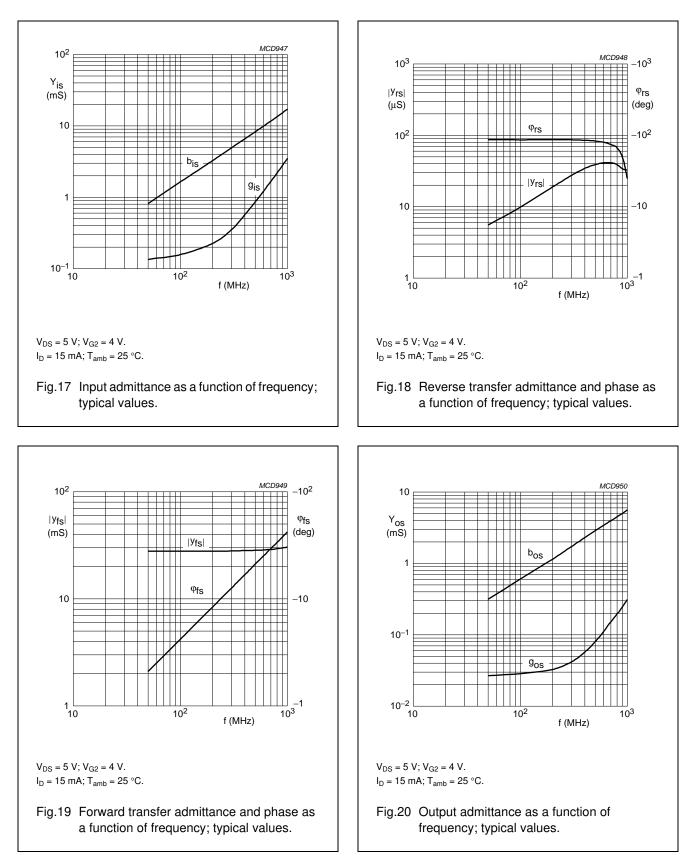
Note

1. Measured in Fig.21 test circuit.









BF1201; BF1201R; BF1201WR

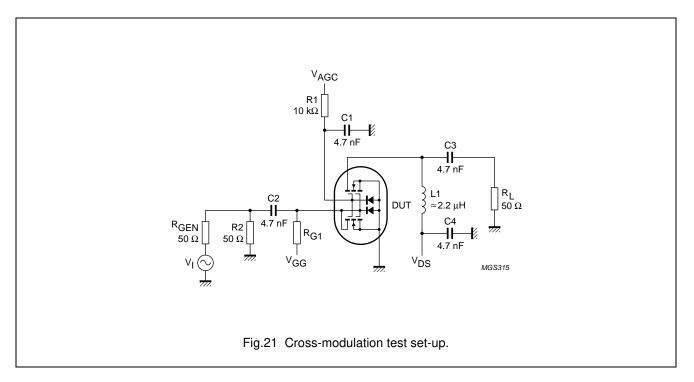


Table 1 Scattering parameters: V_{DS} = 5 V; V_{G2-S} = 4 V; I_D = 15 mA; T_{amb} = 25 °C

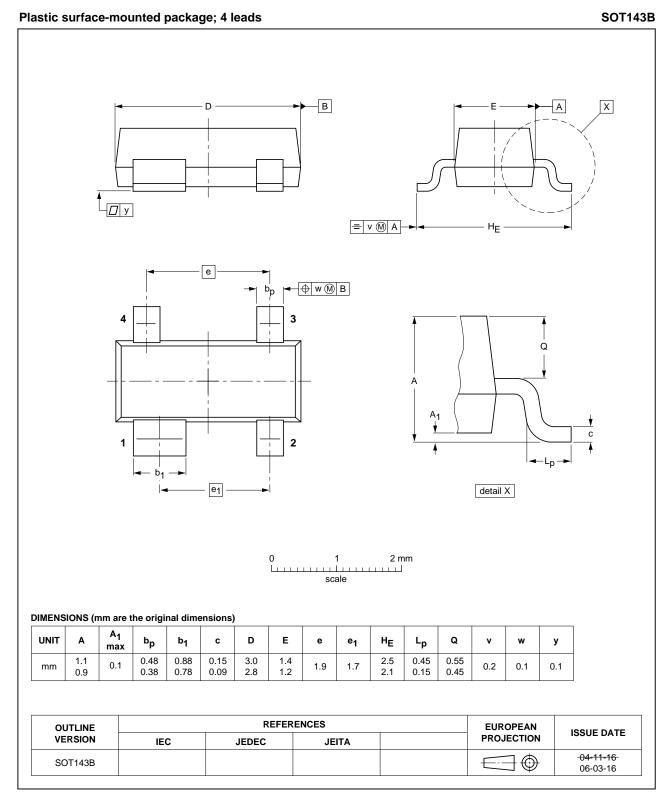
4	S ₁₁		S ₂₁		s ₁₂		S ₂₂	
ı (MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)
50	0.987	-4.72	2.775	174.6	0.0006	88.8	0.997	-1.84
100	0.985	-9.39	2.774	169.5	0.0010	86.7	0.997	-3.37
200	0.978	-18.59	2.731	159.1	0.0019	79.7	0.996	-6.72
300	0.976	-27.74	2.671	148.8	0.0026	74.2	0.994	-10.02
400	0.949	-36.59	2.599	138.8	0.0032	69.9	0.992	-13.33
500	0.928	-45.08	2.501	129.1	0.0035	65.9	0.989	-16.55
600	0.905	-53.26	2.400	119.8	0.0035	64.6	0.986	-19.64
700	0.882	-61.07	2.297	110.9	0.0033	65.7	0.982	-22.63
800	0.860	-68.48	2.199	102.4	0.0029	69.1	0.979	-25.54
900	0.838	-75.55	2.096	94.2	0.0024	83.3	0.975	-28.44
1000	0.818	-82.23	1.997	86.3	0.0021	103.8	0.971	-31.42

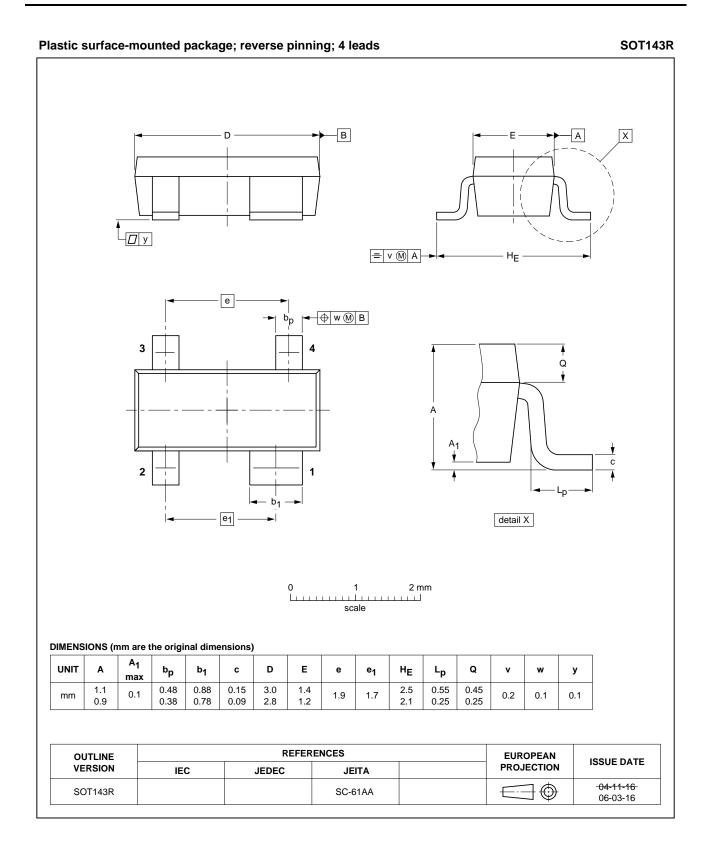
Table 2 Noise data: $V_{DS} = 5 \text{ V}$; $V_{G2-S} = 4 \text{ V}$; $I_D = 15 \text{ mA}$; $T_{amb} = 25 \text{ °C}$

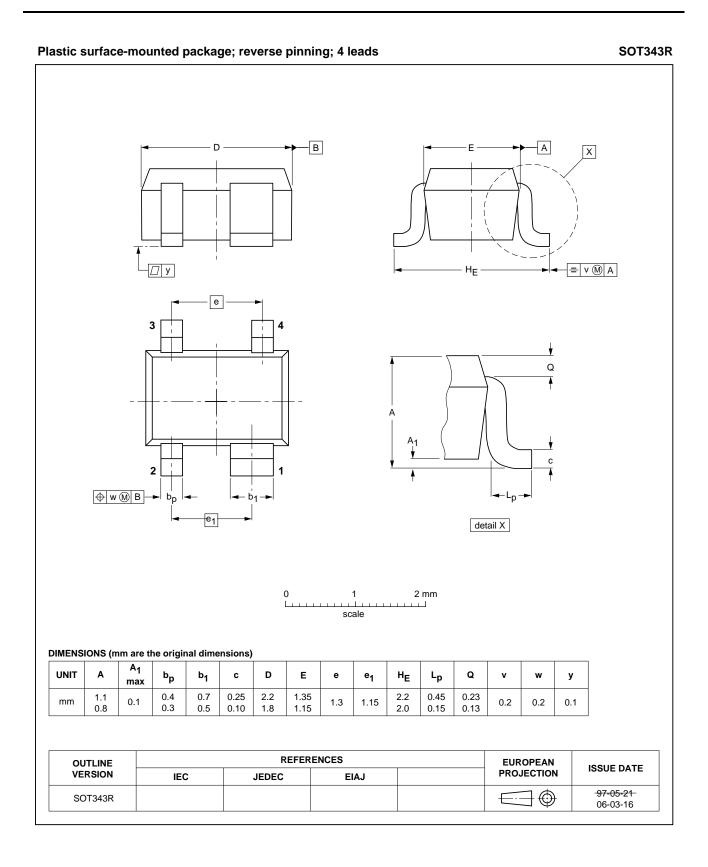
f	F _{min}	Г	opt	R _n			
(MHz)	(dB)	(ratio)	(deg)	(Ω)			
400	1	0.825	38.93	50			
800	1.9	0.753	70.65	38.75			

BF1201; BF1201R; BF1201WR

PACKAGE OUTLINES







BF1201; BF1201R; BF1201WR

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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BF1201; BF1201R; BF1201WR

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Contact information

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